

**S arch Notes**

Application/Control No.

10/035,891

Examiner

Daniel Tekle

Applicant(s)/Patent und r  
R xamination

SCHRADER, EDWARD M.

Art Unit

2633

**SEARCHED**

Class	Subclass	Date	Examiner
386	96	5/6/2006	DT
386	97	5/6/2006	DT
386	94	5/6/2006	DT
348	468	5/6/2006	DT
386	1	5/6/2006	DT
386	46	5/15/2006	DT
704	275	5/15/2006	DT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
List data base search in East (US-PGPUB, USPAT, USOCR, EPO, JPO, DEWENT, IBM_TDB) see search history attached	5/6/2006	DT
NPL ACM DIGITAL LIBRARY, IEEE Xplore, IP.COM see search history attached	5/6/2006	DT
PLUS See search history attached	5/6/2006	DT
inventor name search	5/6/2006	DT